

Notice of References Cited	Application/Control No. 10/757,217	Applicant(s)/Patent Under Reexamination VOSSEN ET AL.	
	Examiner Scott A. Hughes	Art Unit 3663	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	O'Neill, et al. "Full waveform P-SV reflectivity inversion of surface waves for shallow engineering applications." Exploration Geophysics, 2003
	V	Mi, et al. "Converted wave prestack depth imaging with the nonstationary wavefield extrapolators." CREWES Research Report, 2001
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.